

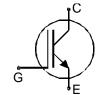
# IGBT<sup>3</sup> Chip

## **FEATURES:**

- 1700V Trench + Field Stop technology
- low turn-off losses
- short tail current
- positive temperature coefficient
- easy paralleling

### This chip is used for:

power module



## Applications:

drives

Chip Type	V <sub>CE</sub>	I <sub>Cn</sub>	Die Size	Package	Ordering Code
SIGC42T170R3G	1700V	29A	6.5 x 6.46 mm <sup>2</sup>	sawn on foil	Q67050- A4261-A101

## **MECHANICAL PARAMETER:**

Raster size	6.5 x 6.46		
Emitter pad size	4.27 x 4.27		
Gate pad size	1.18 x 1.09		
Area total / active	42 / 28.7		
Thickness	190	μm	
Wafer size	150	mm	
Flat position	180	grd	
Max.possible chips per wafer	338 pcs		
Passivation frontside	Photoimide		
Emitter metalization	3200 nm AlSiCu		
Collector metalization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding		
Die bond	electrically conductive glue or solder		
Wire bond	Al, <500μm		
Reject Ink Dot Size	Ø 0.65mm; max 1.2mm		
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C		



### **MAXIMUM RATINGS:**

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T <sub>j</sub> =25 °C	V <sub>CE</sub>	1700	V
DC collector current, limited by T <sub>jmax</sub>	I <sub>C</sub>	1)	Α
Pulsed collector current, t <sub>p</sub> limited by T <sub>jmax</sub>	I <sub>cpuls</sub>	87	Α
Gate emitter voltage	V <sub>GE</sub>	±20	V
Operating junction and storage temperature	$T_j$ , $T_{stg}$	-55 <b>+</b> 150	°C

<sup>1)</sup> depending on thermal properties of assembly

# STATIC CHARACTERISTICS (tested on chip), $T_j$ =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
Tarameter			min.	typ.	max.	
Collector-emitter breakdown voltage	V <sub>(BR)CES</sub>	$V_{GE}$ =0 $V$ , $I_{C}$ = 1.5 $mA$	1700			
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =29A	1.6	2	2.4	V
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	$I_C$ =1.2mA , $V_{GE}$ = $V_{CE}$	5.2	5.8	6.4	
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =1700V , V <sub>GE</sub> =0V			2	μA
Gate-emitter leakage current	I <sub>GES</sub>	V <sub>CE</sub> =0V , V <sub>GE</sub> =20V			600	nA
Integrated gate resistor	R <sub>Gint</sub>			32		Ω

## **ELECTRICAL CHARACTERISTICS** (tested at component):

Parameter	Symbol Con	Conditions	Value			Unit
raiametei	Symbol	Conditions	min.	typ.	max.	Onne
Input capacitance	Ciss	V <sub>CE</sub> =25V,		2500		pF
Output capacitance	Coss	$V_{GE}=0V$ ,		105		
Reverse transfer capacitance	Crss	f=1MHz		84		

## SWITCHING CHARACTERISTICS (tested at component), Inductive Load

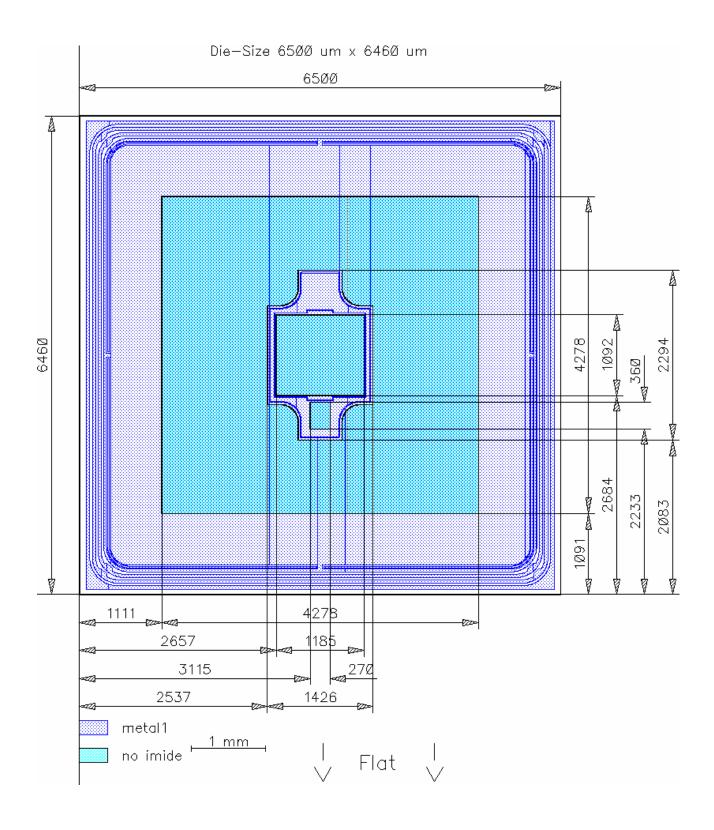
Parameter	Symbol	Conditions 1)	Value			Unit
- arameter			min.	typ.	max.	Onne
Turn-on delay time	$t_{d(on)}$	<i>T</i> <sub>j</sub> =125°C		400		μs
Rise time	$t_{\rm r}$	V <sub>CC</sub> =900V,		50		
Turn-off delay time	$t_{d(off)}$	I <sub>C</sub> =29A, V <sub>GE</sub> =-15/15V,		800		
Fall time	$t_{f}$	$R_{\rm G}$ = 18 $\Omega$		300		

<sup>&</sup>lt;sup>1)</sup> values also influenced by parasitic L- and C- in measurement and package.

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#### **CHIP DRAWING:**





FURTHER ELECTRICAL CHARACTERISTICS:	:	
This chip data sheet refers to the device data sheet		
DESCRIPTION:		
AQL 0,65 for visual inspection according to failure	re catalog	
Electrostatic Discharge Sensitive Device accord	ling to MIL-STD 883	
Test-Normen Villach/Prüffeld		

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